Search Notes				

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/617,197	THUBERT ET AL.	
Examiner	Art Unit	

Frank Duong

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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
EAST Search	1/23/2006	FD
Inventorship Search	1/23/2006	FD
IEEE/Internet Search	1/23/2006	FD